		Notice of References Cited			Application/Control No.		Reexaminat	Applicant(s)/Patent Under Reexamination HIDESAWA, SHIGERU	
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U.S. PATENT DOCUMENTS									
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FOREIGN PATENT DOCUMENTS									
*·		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Count	country Name '		ie	Classification	
*	N	2001-125952	05-2001	Japan		FUJITSU LTD		G06F 17/60	
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